

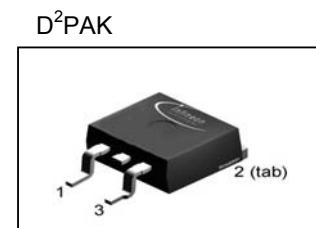
2nd Generation thinQ!TM SiC Schottky Diode

Features

- Revolutionary semiconductor material - Silicon Carbide
- Switching behavior benchmark
- No reverse recovery/ No forward recovery
- No temperature influence on the switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications
- Breakdown voltage tested at 5mA²⁾

Product Summary

V_{DC}	600	V
Q_c	15	nC
I_F	6	A



thinQ! 2G Diode designed for fast switching applications like:

- CCM PFC
- Motor Drives

Type	Package	Marking	Pin 2	Pin 3
IDB06S60C	D ² PAK	D06S60C	C	A

Maximum ratings, at $T_j=25$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous forward current	I_F	$T_C < 135$ °C	6	A
RMS forward current	$I_{F,RMS}$	$f=50$ Hz	9	
Surge non-repetitive forward current, sine halfwave	$I_{F,SM}$	$T_C = 25$ °C, $t_p = 10$ ms	46	
Repetitive peak forward current	$I_{F,RM}$	$T_j = 150$ °C, $T_C = 100$ °C, $D = 0.1$	24	
Non-repetitive peak forward current	$I_{F,max}$	$T_C = 25$ °C, $t_p = 10$ µs	210	
i^2t value	$\int i^2 dt$	$T_C = 25$ °C, $t_p = 10$ ms	10	A ² s
Repetitive peak reverse voltage	V_{RRM}		600	V
Diode ruggedness dv/dt	dv/dt	$V_R = 0 \dots 480$ V	50	V/ns
Power dissipation	P_{tot}	$T_C = 25$ °C	52	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	2.9	K/W
Thermal resistance, junction - ambient	R_{thJA}	SMD version, device on PCB, minimal Footprint	-	-	62	
		SMD version, device on PCB, 6 cm ² cooling area ³⁾	-	35	-	
Soldering temperature, reflowsoldering @ 10sec	T_{sold}	reflow MSL1	-	-	260	°C

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified

Static characteristics						
DC blocking voltage	V_{DC}	$I_R=0.08$ mA	600	-	-	V
Diode forward voltage	V_F	$I_F=6$ A, $T_j=25$ °C	-	1.5	1.7	
		$I_F=6$ A, $T_j=150$ °C	-	1.7	2.1	
Reverse current	I_R	$V_R=600$ V, $T_j=25$ °C	-	0.7	80	μA
		$V_R=600$ V, $T_j=150$ °C	-	3	800	

AC characteristics

Total capacitive charge	Q_c	$V_R=400$ V, $I_F \leq I_{F,max}$, $di_F/dt=200$ A/μs, $T_j=150$ °C	-	15	-	nC
Switching time ⁴⁾	t_c		-	-	<10	ns
Total capacitance	C	$V_R=1$ V, $f=1$ MHz	-	280	-	pF
		$V_R=300$ V, $f=1$ MHz	-	35	-	
		$V_R=600$ V, $f=1$ MHz	-	35	-	

¹⁾ J-STD20 and JESD22

²⁾ All devices tested under avalanche conditions, for a time period of 5ms at 5mA.

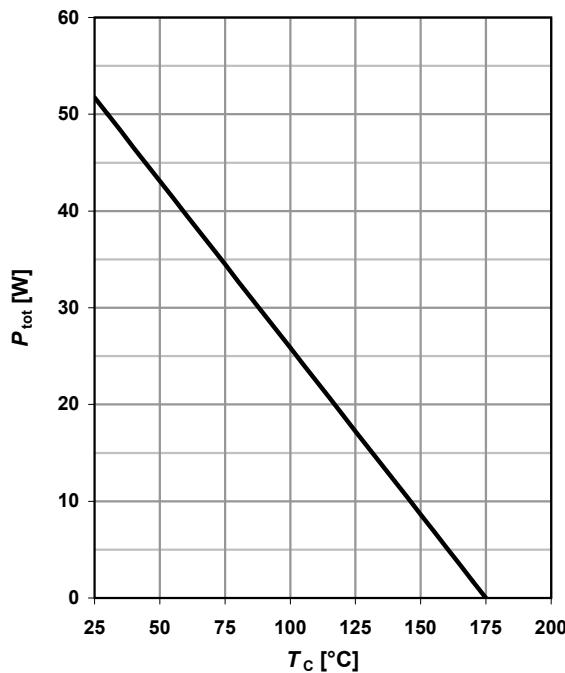
³⁾ Device on 40mm*40mm*1.5mm epox PCB FR4 with 6cm² (one layer, 70μm thick) copper area for drain connection. PCB is vertical with out blown air.

⁴⁾ t_c is the time constant for the capacitive displacement current waveform (independent from T_j , I_{LOAD} and di/dt), different from t_{rr} , which is dependent on T_j , I_{LOAD} , di/dt . No reverse recovery time constant t_{rr} due to absence of minority carrier injection.

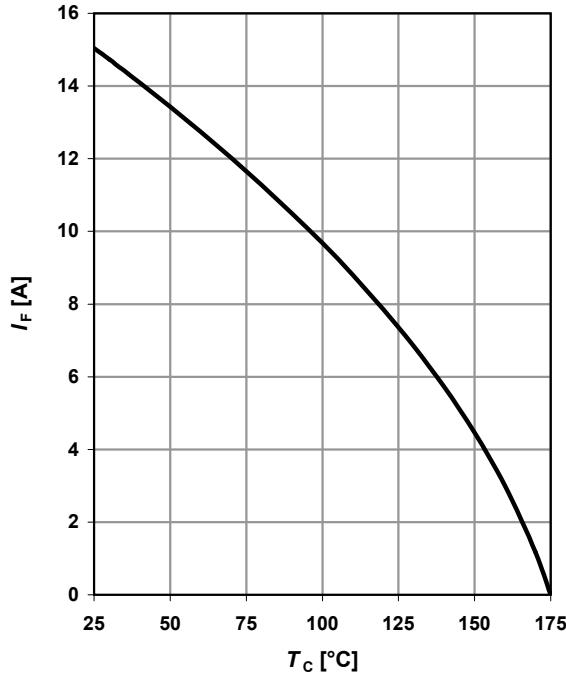
⁵⁾ Only capacitive charge occurring, guaranteed by design.

1 Power dissipation

$$P_{\text{tot}} = f(T_c)$$

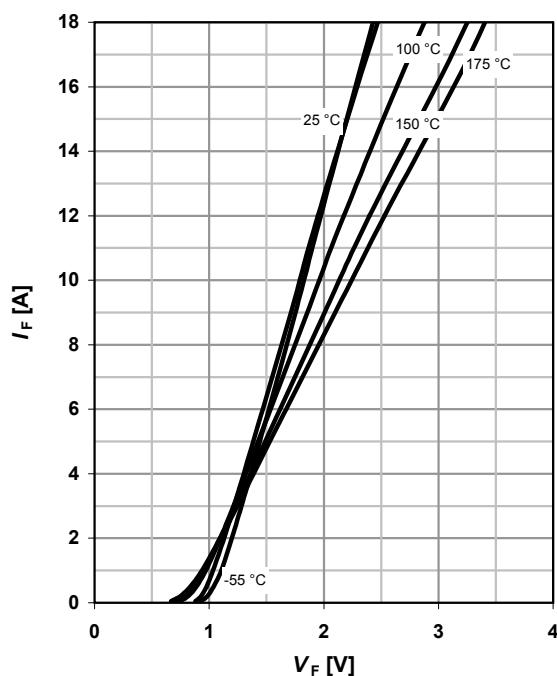

2 Diode forward current

$$I_F = f(T_c); T_j \leq 175^\circ\text{C}$$

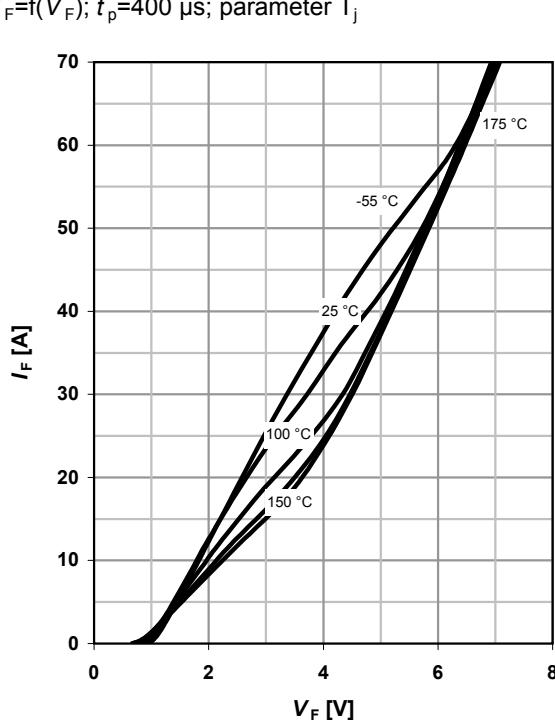

3 Typ. forward characteristic

$$I_F = f(V_F); t_p = 400 \mu\text{s}$$

parameter: T_j

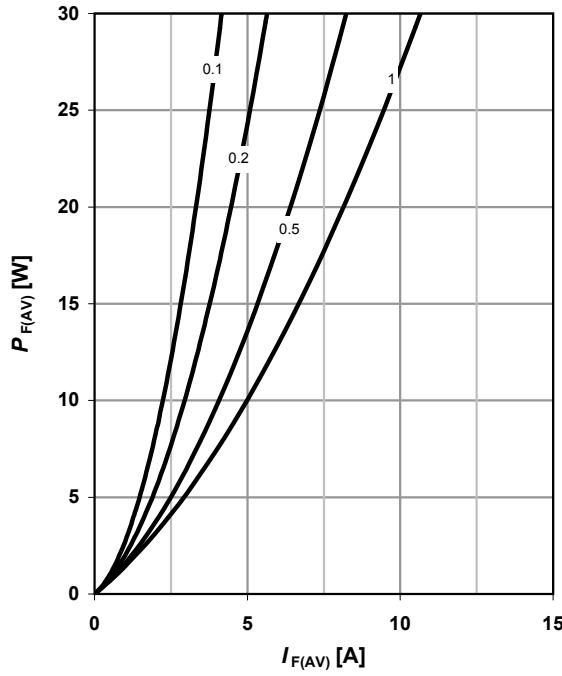

4 Typ. forward characteristic in surge current mode

$$I_F = f(V_F); t_p = 400 \mu\text{s}; \text{parameter } T_j$$



**5 Typ. forward power dissipation vs.
average forward current**

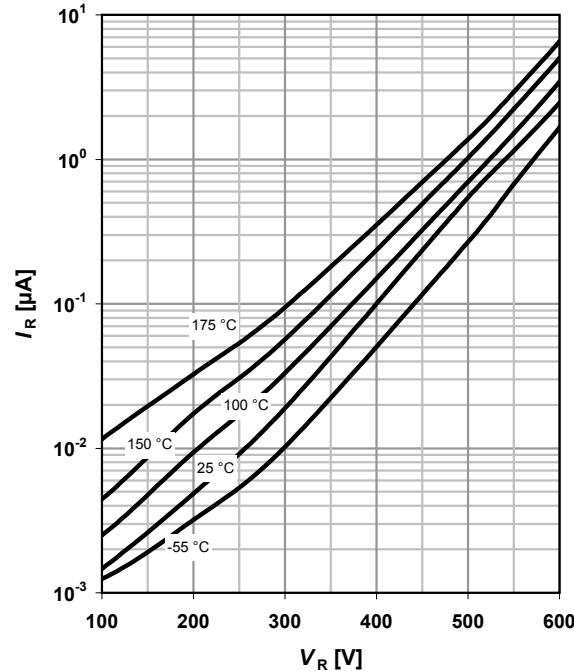
$P_{F,AV}=f(I_F)$, $T_C=100\text{ }^\circ\text{C}$, parameter: $D=t_p/T$



6 Typ. reverse current vs. reverse voltage

$I_R=f(V_R)$

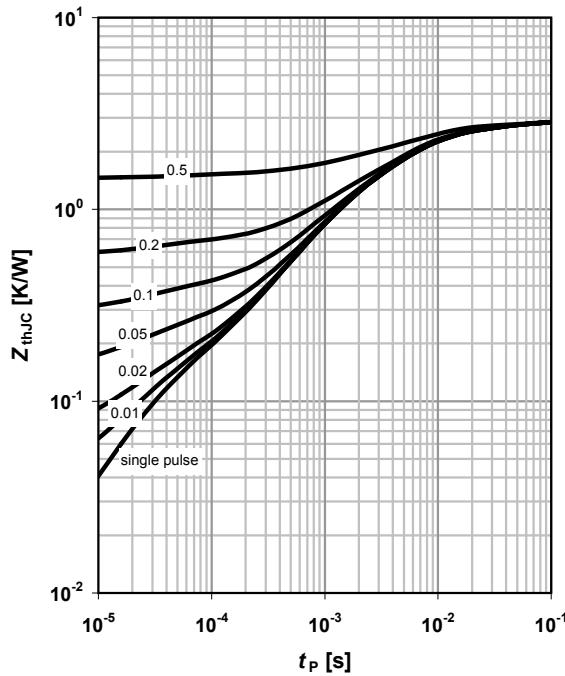
parameter: T_j



7 Transient thermal impedance

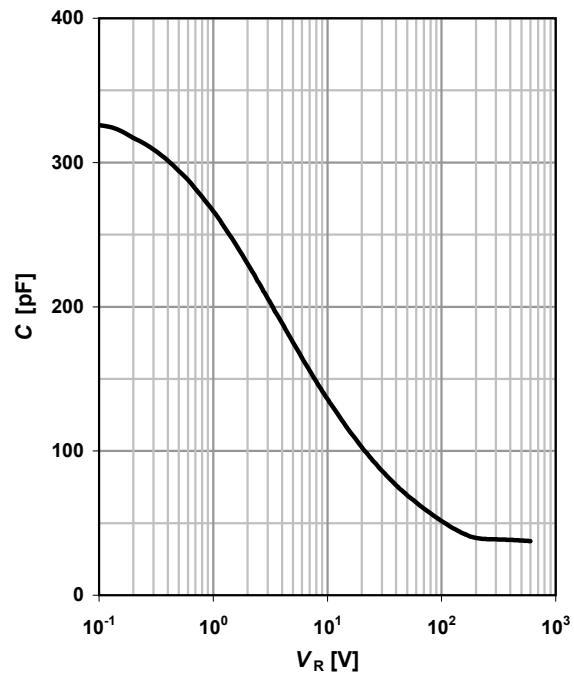
$Z_{thJC}=f(t_p)$

parameter: $D=t_p/T$



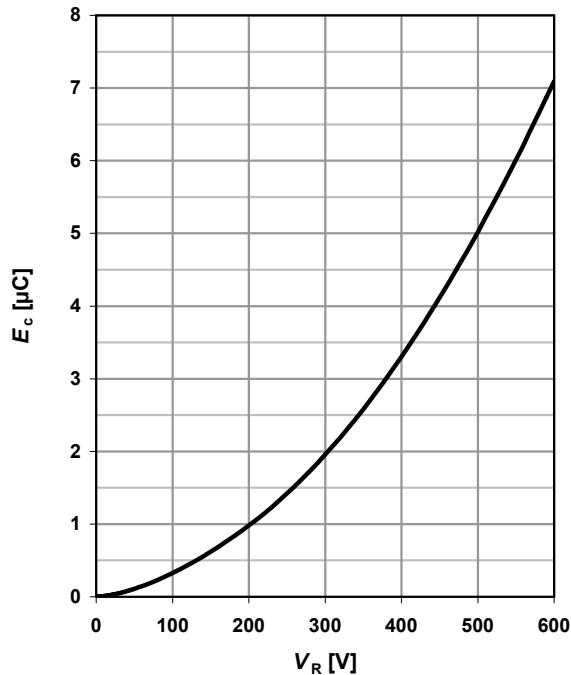
8 Typ. capacitance vs. reverse voltage

$C=f(V_R)$; $T_C=25\text{ }^\circ\text{C}$, $f=1\text{ MHz}$

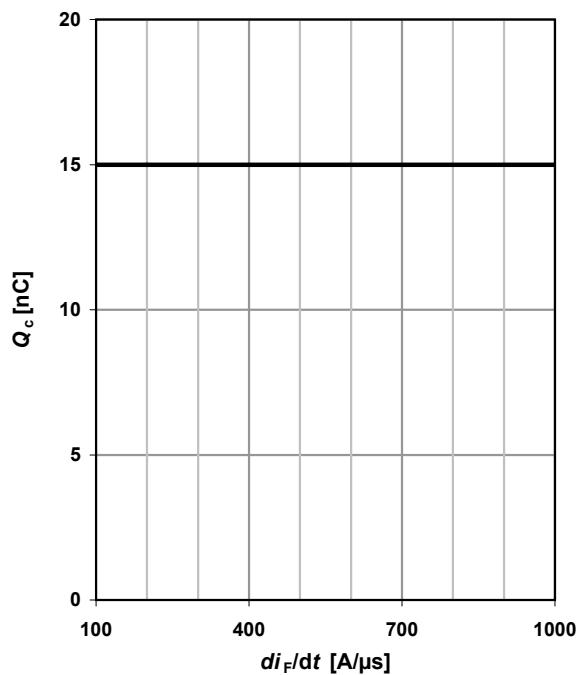


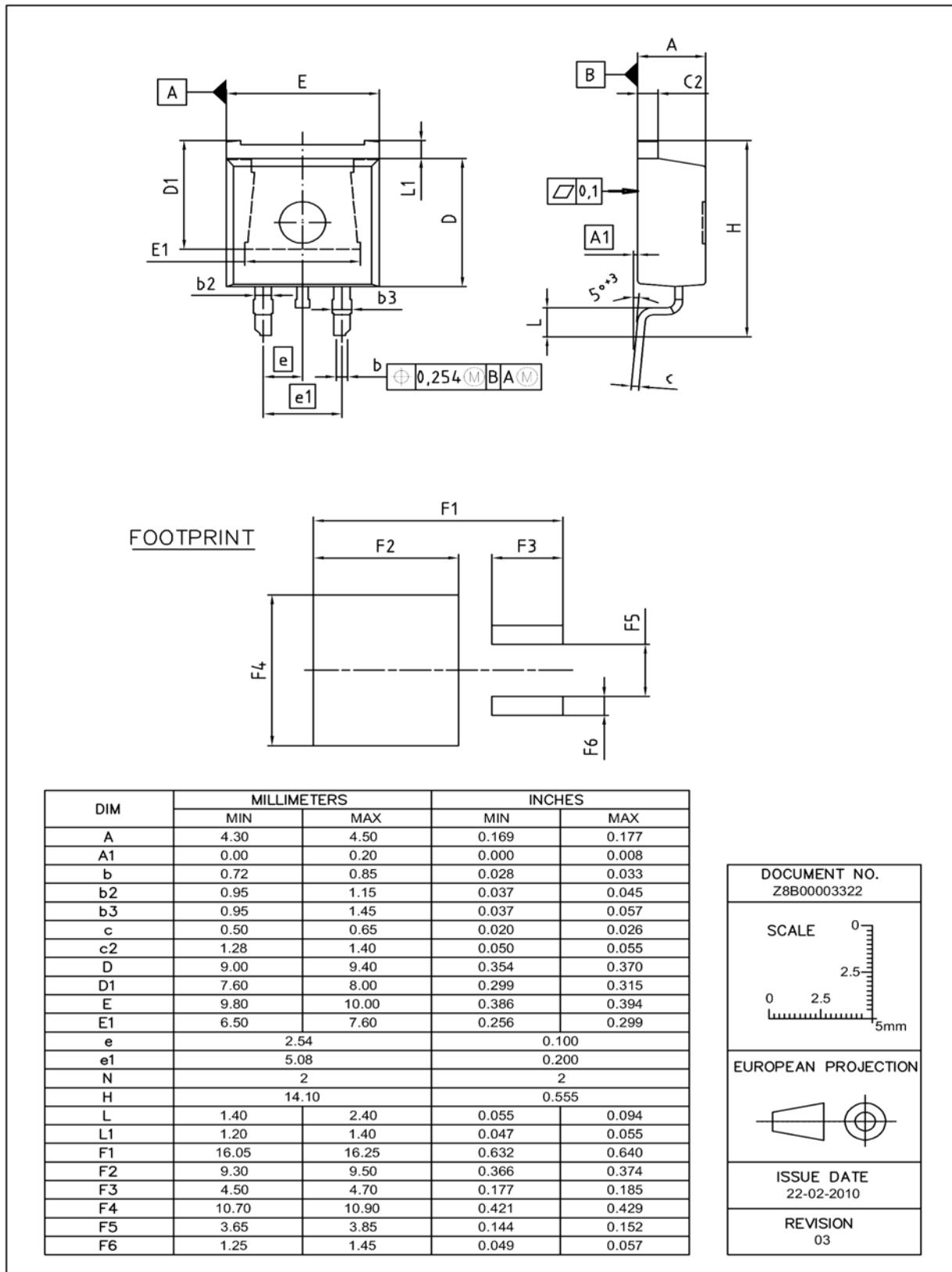
9 Typ. C stored energy

$$E_C = f(V_R)$$


10 Typ. capacitance charge vs. current slope

$$Q_C = f(di_F/dt)^{5/2}, \quad T_J = 150^\circ\text{C}; \quad i_F \leq i_{F,\max}$$



PG-T0220-3-45 (D2Pak): Outline


Dimensions in mm/inches

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